

Search Notes

Application/Control No.

10/534,491

Examiner

Luan K. Bui

Applicant(s)/Patent under
Reexamination

MASUDA ET AL.

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
206	219, 220	9/25/2006	LKB
	568, 438		
	459.1		
	459.5		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR